

Notice of References Cited	Application/Control No. 10/789,056	Applicant(s)/Patent Under Reexamination LIN, CHUN-WEI	
	Examiner Anna Gofman	Art Unit 1771	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,332,858	06-1982	Saitoh et al.	428/412
*	B	US-5,333,662	08-1994	Costemalle et al.	152/510
*	C	US-4,007,311	02-1977	Harlan, Jr., James T.	442/149
*	D	US-3,919,035	11-1975	Warrach, Wolfgang	156/315
*	E	US-4,251,642	02-1981	Tan et al.	525/66
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.